

Half-integer Shapiro steps in InSb/Nb Josephson junctions

A. Iorio¹, B. Turini¹, S. Salimian¹, M. Carrega², L. Chirolli¹, A. Crippa¹, E. Strambini¹, V. Zannier¹, L. Sorba¹, F. Giazotto¹, and S. Heun¹

¹NEST, Istituto Nanoscienze-CNR and Scuola Normale Superiore, Pisa, Italy

²CNR-SPIN, Via Dodecaneso 33, 16146 Genova, Italy

InSb is a high-quality narrow band gap semiconductor with strong spin-orbit coupling, which makes it the ideal platform to develop architectures able to coherently control new states of matter with topological properties. We present transport data on hybrid Josephson junctions made from InSb nanoflags with Nb contacts. These InSb nanoflags have a typical size of $L \sim 2.8 \mu\text{m}$, $W \sim 500 \text{ nm}$, and $d \sim 100 \text{ nm}$. A mobility of $29.500 \text{ cm}^2/(\text{Vs})$ at an electron density of $8.5 \times 10^{11} \text{ cm}^{-2}$ is measured, which results in an electron mean free path $\ell_e \sim 500 \text{ nm}$ [1]. At variance to previous work [1-3], in the junctions presented here the Nb is directly deposited on the S-passivated InSb nanoflags.

The junction discussed in the following has a length L of 80 nm and a width W of 700 nm. Since $\ell_e > L$, the transport in the junction is ballistic. The Nb has a critical temperature of $\sim 8.9 \text{ K}$. This corresponds to a BCS gap of $\sim 1.3 \text{ meV}$, so that the induced superconducting coherence length exceeds L , which places the device in the short-junction limit. At 30 mK, the junction shows a critical current above 100 nA. The temperature dependence of the critical current above 500 mK is well described by a short-junction model with interface transparency 0.8. However, a detailed analysis of the full temperature range suggests that the current in the junction is the sum of the short channel contribution and a long channel contribution, for which a path length of about $5 \mu\text{m}$ is obtained (Fig. 1). This result is consistent with the quantitative analysis of the anomalous Fraunhofer pattern measured on the same junction (Fig. 2). Finally, irradiating the junction with microwaves, half-integer Shapiro steps are observed (Fig. 3), which are robust in temperature and persist up to 1 K. Possible explanations for these observations will be discussed in the seminar.

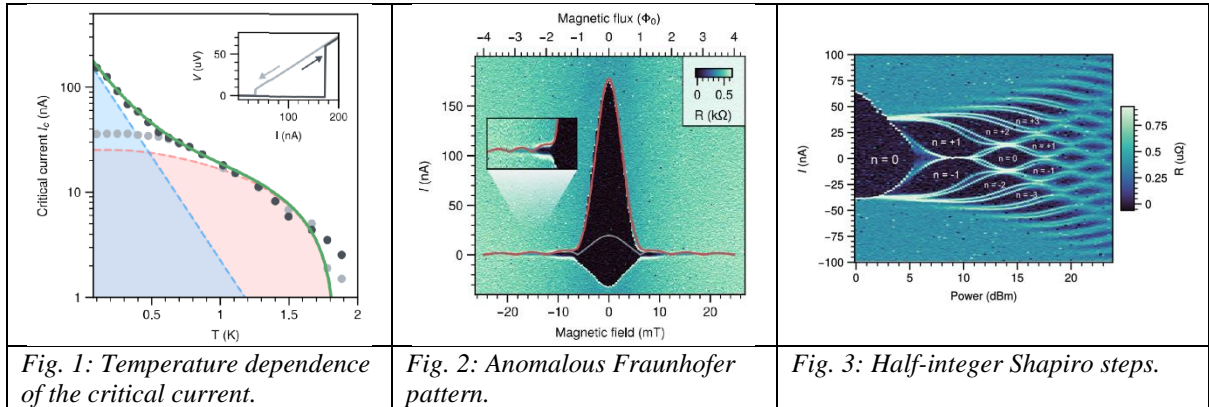


Fig. 1: Temperature dependence of the critical current.

Fig. 2: Anomalous Fraunhofer pattern.

Fig. 3: Half-integer Shapiro steps.

- [1] I. Verma et al., ACS Appl. Nano Mater. 4, 5825 (2021).
- [2] S. Salimian et al., Appl. Phys. Lett. 119, 214004 (2021).
- [3] B. Turini et al., Nano Lett. 22, 8052 (2022).

Helpful discussions with Michal Nowak are gratefully acknowledged. Furthermore, we acknowledge funding by the FET-OPEN project AndQC (H2020 Grant No. 828948) and the EU's Horizon 2020 research and innovation program under Grant Agreement No. 800923 (SUPERTED) and No. 964398 (SUPERGATE).